

<b>Notice of References Cited</b>	Application/Control No. 10/698,394	Applicant(s)/Patent Under Reexamination SHIMIZU, TESSEI	
	Examiner Thu Nguyen	Art Unit 3661	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,714,857 B2	03-2004	Kapolka et al.	701/123
	B	US-6,636,790 B1	10-2003	Lightner et al.	701/33
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002-197155	07-2002	Japan	Riu et al	G06F 17/60
	O	JP 2002-089349	03-2002	Japan	Satoshi et al	F02D 45/00
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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